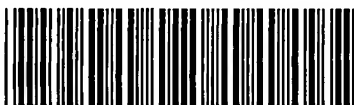


Search Notes

Application/Control No.

10/643,669

Examiner

John Kim

Applicant(s)/Patent under
Reexamination

TANNER ET AL.

Art Unit

1723

SEARCHED

Class	Subclass	Date	Examiner
210	501, 502.1, 504, 505, 506, 508	6/27/2007	JK
	266, 282		
	497.1		
	473, 477		
	252, 259		
	257.1		
	257.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	3/1/2006	YK
See EAST Search History 210/501,502.1,504,505,506,508,266,2 82,497.1,473,477,252,257.1,257.2,25 9	3/3/2006	YK
EAST Search History	8/23/2006	JK
EAST Search History	6/27/2007	JK